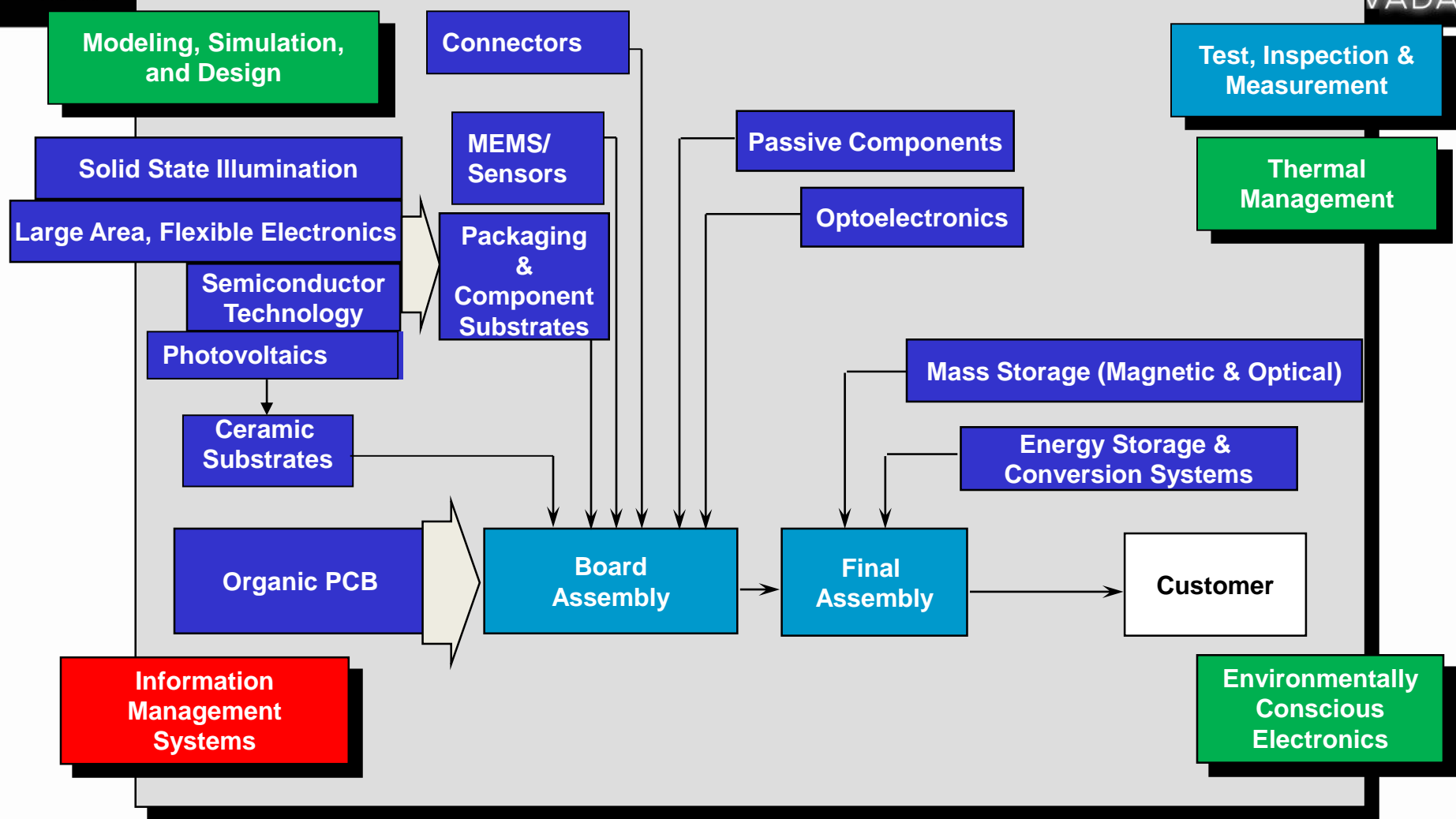


# INEMI Rework Roadmap

Jasbir Bath

## INEMI Roadmap

- TWG - Technical Working Group
  - Develops the roadmap technology chapters
  - Presently 20 groups/chapters for the roadmap
  - Roadmap released every 2 years



Red=Business

Green=Engineering

Aqua=Manufacturing

Blue=Component & Subsystem

## 2013 Technology Working Groups (TWGs)

## Statistics for INEMI 2013 Roadmap

- > 650 participants
  - > 350 companies/organizations
  - 18 countries from 4 continents
  - 20 Technology Working Groups (TWGs)
  - 6 Product Emulator Groups (PEGs)
  - > 1,900 pages of information
  - Roadmaps the needs for 2013-2023
  - Workshops held in Europe, Asia and North America
  - Global Perspective
- 
- Available to iNEMI members from 12/22/12 at: [www.inemi.org](http://www.inemi.org)
  - Shipping/Downloading to industry began April 4, 2013 at [www.inemi.org](http://www.inemi.org)

## INEMI Board Assembly Technical Working Group (2013)

### Board Assembly Sections and Chairs (99 pages)

- Assembly Materials: Keith Howell, Nihon Superior
- **Repair & Rework:** Jasbir Bath
- Press-fit: Dennis Willie, Flextronics
- SMT Placement: Girish Wable, Jabil
- NPI: Michael Gerner, Plexus

### Overall Board Assembly Section Chair and Co-chair

- Dr. Paul Wang, Mitac
- Frank Grano, GE
- 51 participants from 33 companies

## INEMI Rework and Repair Section (2013)

- Updated hand soldering, PTH rework and area array rework sections from 2011 roadmap in relation to tin-lead and lead-free rework soldering technologies.

### Some focus areas included:

- Rework of temperature sensitive components
- Rework of new/emerging components such as QFN/BTC and PoP components.
- Understanding if there are changes in the types of alloy materials used during lead-free rework.

Group consisted of OEMs, EMS, soldering material and rework equipment suppliers and rework training companies.

## Hand Solder Rework

### Hand Solder Rework

Soldering Process	Parameter	Units	2011	2013	2015	2017	2023
Pb-free	Soldering iron peak temperature used	°C	375	375	375	375	375
	Total contact time	sec	6	6	6	6	6
	Smallest lead-frame pitch to be reworked by hand	mm	0.4	0.4	0.3	0.3	0.3
	Smallest type of discretes being reworked	-	0201	0201	01005	01005	01005
	Type of wire alloy used	-	SAC305/ SnCuNi (low tip dissolution alloys)	SAC305/ SnCuNi (low tip dissolution alloys)	SAC305/ SnCuNi (low tip dissolution alloys)	SAC305/ SnCuNi (low tip dissolution alloys)	SAC305/ SnCuNi (low tip dissolution alloys)

Component pitch down to 0.3mm,  
Component size down to 01005[Imperial]/ (0402 metric)

## PTH Rework (Challenges)

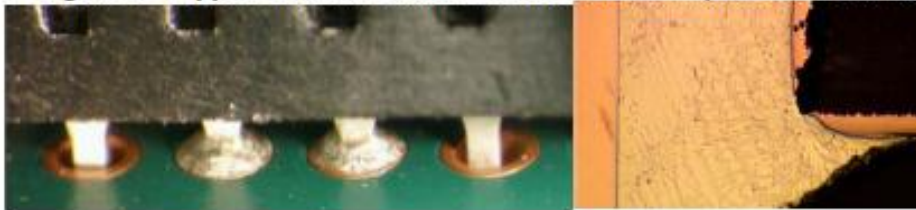
Table 22: Convection Connector Rework Temperatures (Ref: VJ Electronix)

	Overall Board Bottomside Preheat Temperature	Localized Bottomside PCB Temperature	Localized Topside PCB Temperature
Single Point Rework	125 – 150°C	240 – 260°C	235 – 250°C
Connector Removal	125 – 150°C	240 – 260°C	240 – 260°C
Barrel Scavenge	125 – 150°C	240 – 260°C	250 – 270°C
Connector Replace	125 – 150°C	240 – 260°C	240 – 260°C

Board Preheat  
temperatures: 150C

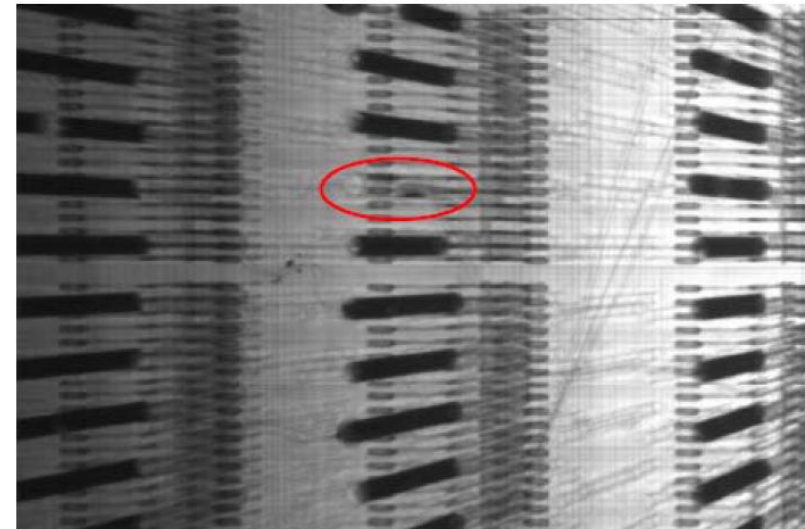
Board Peak Temperatures:  
up to 270C

Figure 9: Copper Dissolution and Insufficient Hole fill (Ref: Celestica 200)



Copper dissolution/ Insufficient Holefill

Figure 7: Missing solder in TH barrel pin to rework. Ref: VJ Electronix



## PTH rework (SnPb versus Lead-free)

Pin Through Hole Rework							
Soldering Process	Parameter	Units	2011	2013	2015	2017	2023
SnPb	Type of preheat used	-	Convection/IR	Convection/IR	Convection/IR	Convection/IR	Convection/IR
	Rework approach (See note)	-	1, 2	1, 2	1, 2	1, 2	1, 2
	PTH rework by hand	%	5	5	5	5	5
Pb-free	Type of preheat used	-	Convection/IR	Convection/IR	Convection/IR	Convection/IR	Convection/IR
	Rework approach (See note)	-	1, 2	1, 2	1, 2	1, 2	1, 2
	PTH rework by hand	%	10	10	10	10	10
Note: Rework Approach Options: 1-Remove and replace within one cycle, 2-Remove in one cycle, remove solder (by hand/ automated), then replace in another cycle							

More challenges to remove and replace component in one cycle  
More rework by hand-soldering for lead-free

### Pin Through Hole Rework

Soldering Process	Parameter	Units	2011	2013	2015	2017	2023
Pb-free	Alloy type used	-	SAC305/ SnCuNi (low copper barrel dissolution)	SAC305/ SnCuNi (low copper barrel dissolution)	SAC305/ SnCuNi (low copper barrel dissolution)	SAC305/ SnCuNi (low copper barrel dissolution)	SAC305/ SnCuNi (low copper barrel dissolution)
	Type of preheat used	-	Convection /IR	Convection /IR	Convection /IR	Convection /IR	Convection /IR
	Board preheat temperature if preheat is used(depends on board thickness)	°C	125-155	125-155	125-155	125-155	125-155
	Max. Pot temperature	°C	260-275	260-275	260-275	260-275	260-275
	Total component contact time	Sec	10	15-30	15-30	15-30	15-30
	Minimum remaining board copper thickness required	Um	12.7	12.7	12.7	12.7	12.7
	Rework approach (See Notes 1 & 2)	-	1, 2	1, 2	1, 2	1, 2	1, 2
	Typical Pin to Hole Area Ratios (Note 3)		0.15-0.35	0.15-0.35	0.15-0.35	0.15-0.35	0.15-0.35
	PTH rework by hand	%	10	10	10	10	10

Note 1: Rework Approach Options: 1-Remove and replace within one cycle, 2-Remove in one cycle, remove solder (by hand/ automated), then replace in another cycle

Note 2: The number of reworks will be dependent on the total component contact time which cannot be exceeded and the minimum remaining board copper thickness limits.

## PTH Rework

SnAgCu and  
SnCuNi alloys

Board preheat up  
to 155C

Up to 275C solder  
pot temperatures

Up to 30 seconds  
component  
contact time.

## Area Array Rework

- Rework of New/Non-Standard Components
- Site Dressing Rework Process
- Re-Attach Rework Process

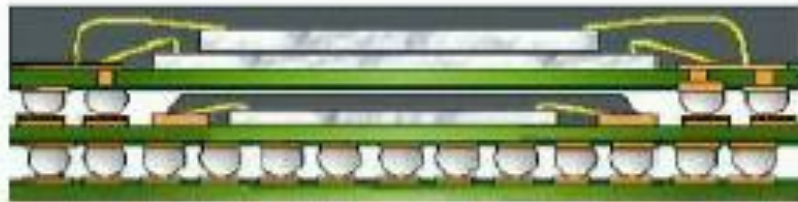


Figure 11: Ref: Sjoberg, J., et al, Flextronics, "Process Development and Reliability Evaluation for Inline Package on Package (PoP) Assembly", SMTAI, 2007

Soldering Process	Parameter	Units	2011	2013	2015	2017	2023
	Maximum package temperature	°C	245-260C	245-260C	245-260C	245-260C	245-260C
	Minimum reworkable pitch	mm	0.4	0.4	0.4	0.4	0.3
	Minimum solder joint temperature	°C	235	235	235	235	235
	Target delta T across solder joints	°C	<10	<10	<10	<10	<10
	Typical rework profile length (time)	min	8	8	8	8	8
	Time Above Liquidus (TAL)	sec	60-90	60 - 90	60 - 90	60 - 90	60 - 90
	Number of allowable area array reworks at a specific location	#	3	3	3	3	3
	Type of rework (Conv./IR/Other) (Other is Laser and Vapor Phase Rework)	%	85/15	85/15	85/15	80/20	70/20/10
	Type redress approach (Non Contact/Solder Wick)	%	20/80	20/80	20/80	30/70	40/60
	Preheat temperature (topside board temperature)	°C	125	125-150	125-150	125-150	125-150
	Currently observe secondary reflow of adjacent reflow (0.150" [3.8mm] away)	-	Yes	Yes	Yes	Yes	Yes

## Area Array Rework

Board preheat: up to  
150C

260C max. peak temp.

Target temp. delta  
<10C

No. of reworks: up to 3

Increased non-contact  
site redressing

Area Array and Non-Standard Package Rework							
Soldering Process	Parameter	Units	2011	2013	2015	2017	2023
Pb-free	Maximum package size	mm	50	50	55	60	75
	Minimum package size	mm	5	2	1.5	1.5	1
	Smallest type of discretes being reworked	-	0201 (Imperial)	0201 (Imperial)	01005 (Imperial)	0201 metric	0201 metric
	Minimum re-workable pitch	mm	0.4	0.4	0.4	0.3	0.3
	Target delta T across solder joints	°C	<10	<10	<10	<10	<10
	Typical rework profile length (time)	min	8	8	8	8	8
	Time Above Liquidus (TAL)	sec	60 - 90	60 - 90	60 - 90	60 - 90	60 - 90
	Number of allowable area array reworks at a specific location	#	3	3	3	3	3
	Type of rework (Conv./IR/Other) (Other is Laser and Vapor Phase Rework)	%	85/15	85/15	85/15	80/20	70/20/10
	Type redress approach (Non Contact/Solder Wick)	%	20/80	20/80	20/80	30/70	40/60
	Type of medium deposit for BGA component rework (Paste on PCB/Paste on Part/Flux only) (See Note)	%	40/40/20	40/40/20	40/40/20	40/40/20	40/40/20

## Area Array Rework (Component size)

Up to 75mm package size

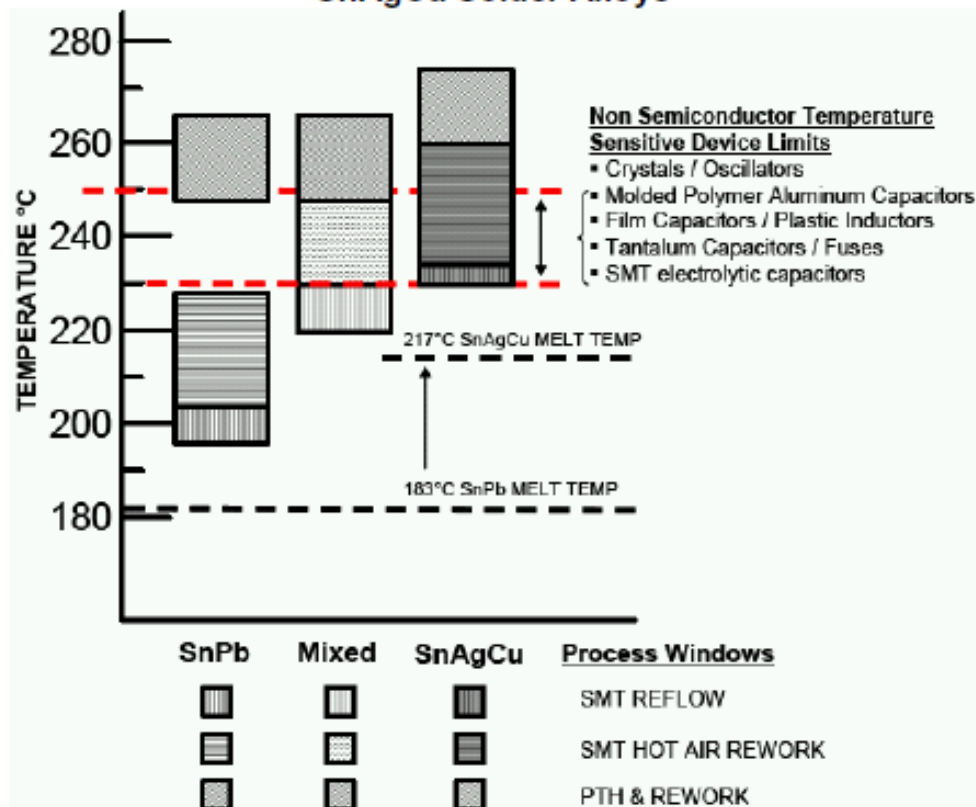
Down to 1mm package size

0201 metric chip

Challenge to have <10C  
target delta T

# Rework of Temperature Sensitive Devices

**Figure 13: Rework Process Temperature Range Corresponding to Tin-Lead and Lead-Free SnAgCu Solder Alloys**



Source of data: Pymonto, L., et al, IBM, "Process Development with Temperature Sensitive Components in Server Applications", IPC APEX, 2008 Conference

## **REWORK OF TEMPERATURE SENSITIVE COMPONENTS**

- Reduced lead-free rework temperature process window for temperature sensitive components (e.g. aluminum capacitors, inductors, fuses, fiber optics, LED's, etc.).
- J-STD-075 standard includes labeling criteria for temp. sensitive components to identify specific maximum reflow temperatures.
- Continued development by suppliers of these components to extend temperature capability.
- In addition, methods of reworking temp. sensitive components without exceeding the current allowable temp. limitations required.
- Hand solder rework typically used for these temperature sensitive components which creates less temperature issues during rework.
- The use of lower temperature lead-free solder alloys during rework such as Sn58Bi (138C melting temperature) is also being explored.

## REWORK OF NON-STANDARD COMPONENTS

Examples include Package-on-Package (PoP), QFN (or MLF), SMT area array connectors and shields.

### BTC (Bottom Termination Components)

- Multiple ways being used to rework QFN/BTC (or MLF) components with no standardization in the industry on the appropriate rework method to use.
- Issues related to QFN (MLF) also include paste deposition
  - Ability to ensure proper deposition of paste on the internal, staggered rowed 0.4mm terminals can be challenging, especially when pitches down to 0.3mm.
- Mini-stencil paste deposition methods will have to be improved.
- Areas to address include: removal and replacement of the parts, stencil design, solder paste selection, voiding reduction, package body temperature monitoring.
- Studies will need to be done to determine the affect of voiding on the solder reliability of BTC/QFN/LGA components after rework (in terms of mechanical, thermal and electrical reliability).

## **REWORK OF NON-STANDARD COMPONENTS (CONT.)**

### PoP (Package on Package Components)

- Establishing a process of reworking an individual component is a challenge.
- A common practice today is to remove the entire package; however this can cause unnecessary scrap depending on the location of the defect.
- New nozzle designs and process techniques (some rework systems do not require special nozzles) adjusted to remove top package only, or the entire stacked device
- Challenge will be on how to reduce the warpage of the individual packages during the rework operations leading to head-in-pillow defects.
- Pad redress processes for ensuring pad flatness, cleanliness and integrity on top of the bottom component will also have to be addressed.

### SMT area array connectors

- Main issue related to height and thermal mass of the connector, on a large, thermally massive PCB.
- The connector body often blisters, melts and/or discolors, during reflow.
- Development work into new nozzle designs to assist in reworking this connector.

## TECHNOLOGY GAPS (HAND SOLDERING REWORK)

- Development of processes to rework 01005[0402 metric] components
- Development of hand soldering fluxes to be electrically reliable on the board even if not sufficiently heat activated.

## TECHNOLOGY GAPS (PTH REWORK)

- PTH rework for large, complex and high thermal mass PCB assemblies
- Increase in thermal mass causes the need for increased contact times, to enable sufficient heat transfer to successfully remove and replace a PTH connector.
- Increasing board preheat prior to rework and/or pot temperatures up to 275° C especially for the higher temperature SnCuNi based alloys
- Components for lead-free PTH rework are typically only rated up to 270° C.
- Advent of halogen free laminates may result in further gaps with respect to laminate survivability during rework.
- Cost and high copper dissolution properties are driving a change away from using the common SAC305/SAC405 alloys during PTH rework.
  - There are many alternative lead-free alloys available for PTH rework such as SnCuNi based alloys and low melting temperature alloys.

## TECHNOLOGY GAPS (PTH REWORK)- CONT.

- Gap remains in terms of impact of mixing differing lead-free solder alloys during PTH rework.
  - Contamination of mini-pot a concern, as well as reliability of a mixed PTH joint.
- Issue may also force the need to utilize alternative methods of reworking PTH connectors, such as convection, infrared, laser, vapor phase, etc.
  - Other alternative methods of removal and replacement of PTH components using BGA rework equipment is being explored.
- Key gap is obtaining good hole fill for lead-free PTH rework on thicker boards while maintaining board copper barrel thickness.
- The current temperature of the components is limiting the pot temperatures during lead-free PTH rework to obtain good hole fill on thicker boards.
- Need to increase the IPC board standard [IPC 6102] to increase the copper barrel thickness, so that the copper knee thickness after wave soldering and wave rework are above 0.5mils (12.7 $\mu$ m)
- Flux development is also need to be electrically reliable on the board even if not sufficiently heat activated.

## TECHNOLOGY GAPS (AREA ARRAY REWORK)

- Establish a process for reworking large BGA and BGA socket components (greater than 50mm) assembled on thermally massive PCBs, while conforming to J-STD-020 standard.
- Establishing a process for reworking temperature sensitive devices.
- Design standardization on recommended board space “keep out areas” around these area array components without damaging adjacent components.
- Establish a process for reworking new/non-standard component types (i.e. PoP, BTC/QFN)
  - Have common industry procedures for rework for these types of components. (IPC 7711: Repair and Rework procedures for BTCs) [See Procedure 5.8.1.1. and 5.8.1.2 and 5.8.1.3 from 7711 for QFN/BTC rework processes]
- Use of these IPC standards must also take into account the reliability of the flux used in rework to ensure it is properly heat activated during rework
- Rework processes to be developed for non-standard components (shields) or large land array components where center pad not symmetrical & broken down into separate pad areas under part.

## TECHNOLOGY GAPS (AREA ARRAY REWORK)- CONT.

- Further development is needed on site redressing processes during area array rework to prevent:
  - lifted board pads
  - solder mask damage
  - copper pad dissolution
- Development is needed to understand the benefits and disadvantages of the paste printing during array area reattach process during rework on:
  - component
  - paste printing on board
  - paste dispensing on board
  - flux dispensing

## **PRIORITIZED RESEARCH & DEVELOPMENT (HAND SOLDERING REWORK)**

- Process for hand soldering 01005[0402 metric] components in a cost effective manner.
- Guidelines for external bench-top pre-heaters to aid in hand soldering of lead free assemblies.

## **PRIORITIZED RESEARCH & DEVELOPMENT (PTH REWORK)**

- Work is needed to understand the correlation between the copper plating type and copper knee dissolution.
- Recommend parameters for alternative rework methods of reworking PTH connectors, such as convection, infrared, laser, vapor phase, etc.
- Study reliability of single pin repair for connectors exhibiting insufficient solder on one or a few pins.
- Development of the PTH rework process to obtain good hole-fill for lead-free PTH rework on thicker boards while maintaining board copper barrel thickness.
- Development of IPC standards to increase the copper knee thickness of boards so copper knee dissolution during wave rework and wave soldering is less of a concern to reliability.

## **PRIORITIZED RESEARCH & DEVELOPMENT (AREA ARRAY REWORK)**

- Process for reworking large BGAs and BGA sockets (greater than 50mm) using area array rework equipment
- Industry Standardized Process for rework of BTC/QFN/MLF and PoP components using area array rework equipment
- Processes to rework large and thin BGAs and PoP components to reduce component warpage affects during rework leading to Head-in-Pillow component soldering issues.
- Process for reworking temperature sensitive devices using area array rework equipment
- Process for reworking non-standard components using area array rework equipment.
- Process for adhesives rework

## **PRIORITIZED RESEARCH & DEVELOPMENT (OTHER CHALLENGES)**

- For single piece RF shields the reliable removal and replacement is challenging for hand soldering or machine rework especially with components in close proximity to the shield.
- The removal of the RF shield will affect adjacent components which can affect the thermal and mechanical reliability performance of the nearby components.

## **PRIORITIZED RESEARCH & DEVELOPMENT (GENERAL)**

- Increased training of operators and engineers in the correct procedures to rework and repair product boards.
- Development of liquid and tacky flux for hand soldering and PTH rework operations which do not lead to reliability concerns if not properly heat activated.

# INEMI Roadmap Assembly Materials Gaps

Parameter	Definition	2011	2013	2015	2017	2023
Solder Paste	Alloy	SAC/ Modified SnCu/ Low Ag SAC	SAC/ Modified SnCu/ Low Ag SAC	SAC/ Modified SnCu/ Low Ag SAC	SAC/ Modified SnCu/ Low Ag SAC	SAC/ Modified SnCu/ Low Ag SAC
	Alloy (Low Temp)				Low Temp	Low Temp
	Alloy (Lead-free)	High Temp	High Temp	High Temp	High Temp	High Temp
	High Temp>260C					
	Halogen-free					
Bar Solder	Alloy	SAC/ Modified SnCu/ Low Ag SAC	SAC/ Modified SnCu/ Low Ag SAC	SAC/ Modified SnCu/ Low Ag SAC	SAC/ Modified SnCu/ Low Ag SAC	SAC/ Modified SnCu/ Low Ag SAC
Wave Solder Flux	VOC Free					
	Halogen free					
Flux-cored Solder Wire	Alloy	SAC/ Modified SnCu/ Low Ag SAC	SAC/ Modified SnCu/ Low Ag SAC	SAC/ Modified SnCu/ Low Ag SAC	SAC/ Modified SnCu/ Low Ag SAC	SAC/ Modified SnCu/ Low Ag SAC
Repair Gel/Pasty Fluxes	Flux-cored Solder Wire			More Benign	Left on Board	Left on Board
Repair Liquid Fluxes	Repair Gel/Tacky Fluxes			More Benign	Left on Board	Left on Board
	Repair Liquid Fluxes			More Benign	Left on Board	Left on Board

# INEMI Roadmap Assembly Materials R&D Priorities

## Repair Flux

- Improvements in tacky fluxes for CSPs
- Development of fluxes with benign residues without heat activation in the solder

## INEMI Rework and Repair Section (2015)

### NEXT STEPS/ UPDATES

- Focus on updating hand soldering, PTH rework and area array rework sections from 2013 roadmap in relation to tin-lead and lead-free rework soldering technologies.

#### Some sections to focus on include:

- Updates to rework of components such as QFN/BTC and PoP components
- Lead-free PTH rework of thicker boards.

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